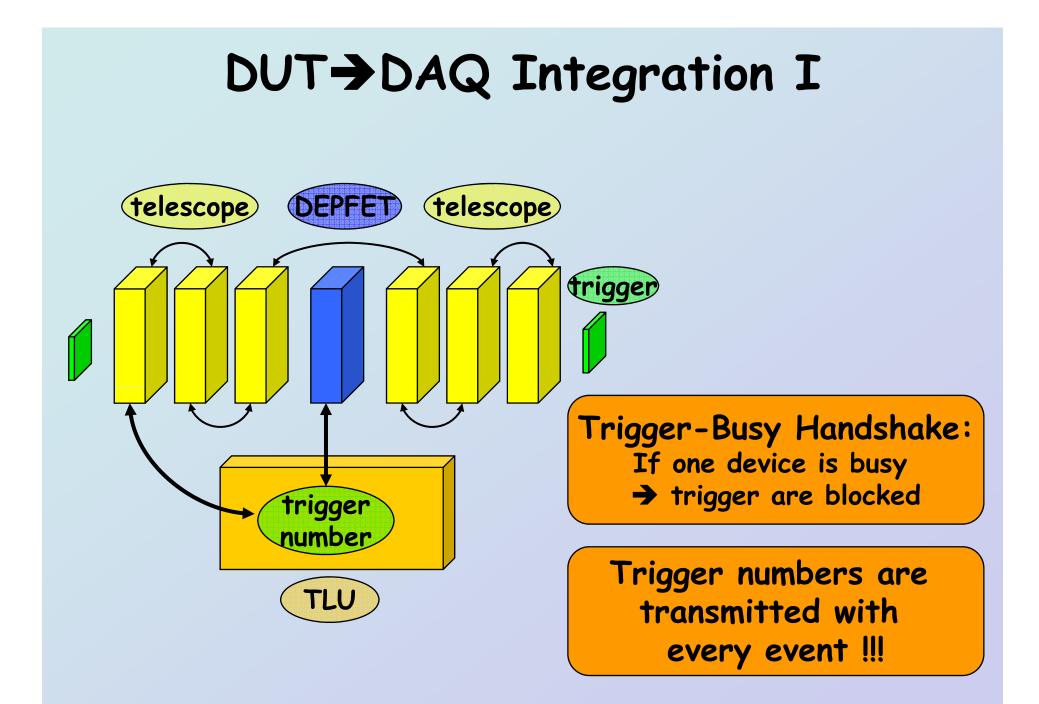
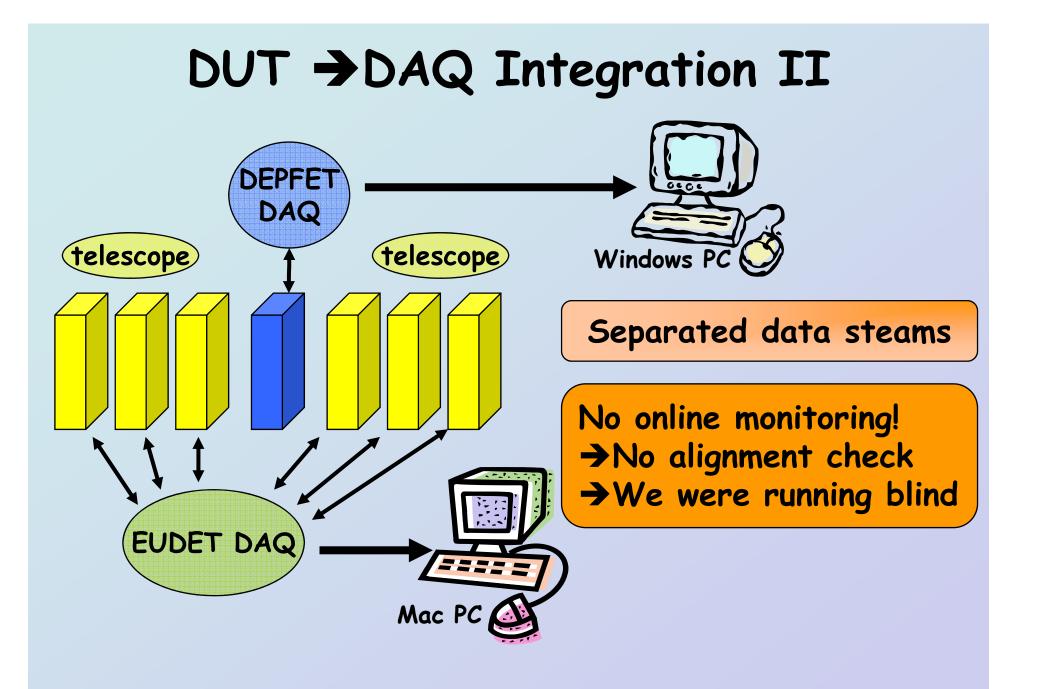
DEPFET as DUT Test Beam Report

Lars Reuen EUDET Meeting, Paris, 2007



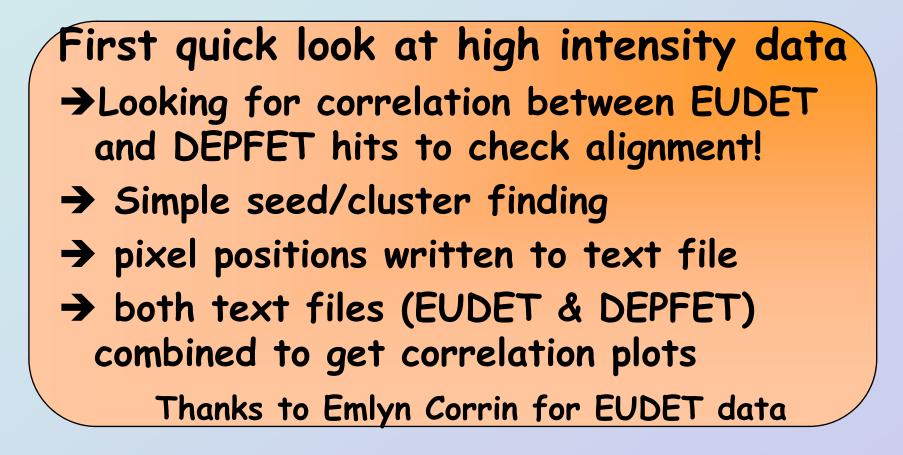


Data Taking

One week of (pure) DEPFET test beam

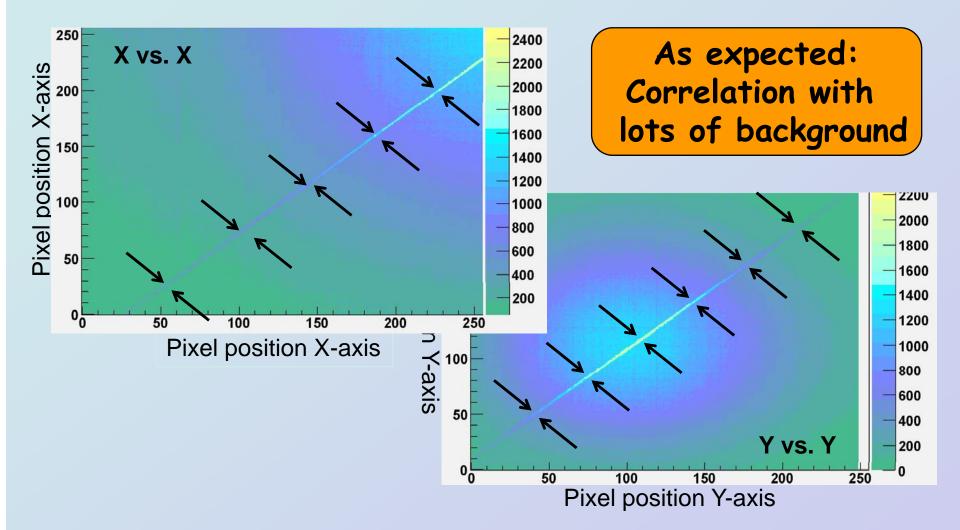
- 3 days as DUT in EUDET test beam
- → Finished 1½ weeks ago
- Results shown here are the definition of preliminary
 - Minor modifications on DEPFET Software
 - Start and Stop (in principle) controlled by EUDET DAQ (via trigger numbers)
 - After one day: Second DEPFET DUT included
 - Very smooth → No crash !!! (rate was low)
 - More than 100k events

First glance at the data

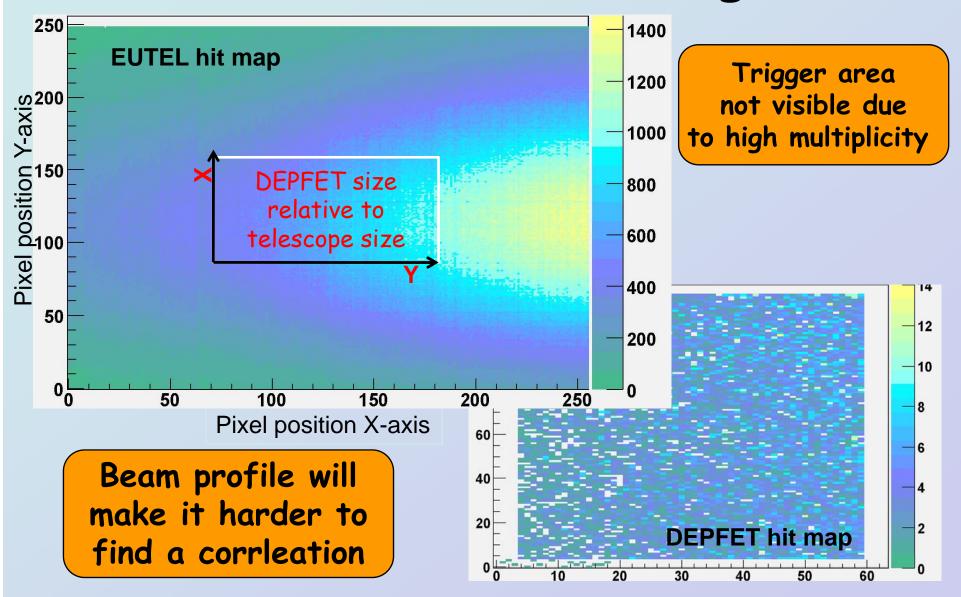


High Intensity Data **Hits/Event** High Multiplicity 40 35 → Hard to see 30 25 any correlation 20 15 10 5 0 **Hits/Event** 2 20 18 16 14 0 10 20 30 40 50 60 70 80 90 EUDET 12 10 20 30 40 50 60 70 80 90 **DEPFET: 1-4 Hits/Event** EUDET: 30-50 Hits/Event 10 20 30 40 50 60 70 80 5 EUDET

EUTEL to EUTEL Correlation

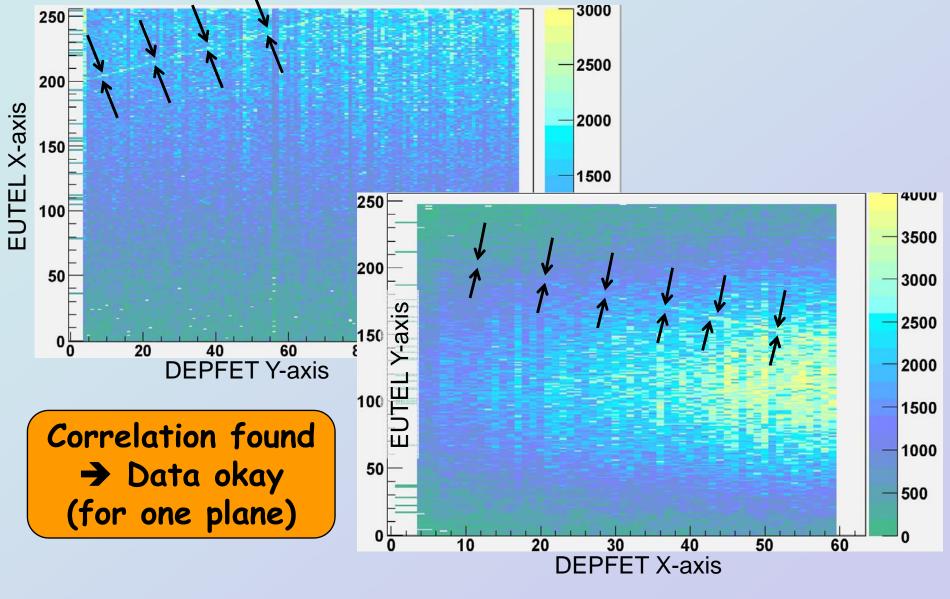


Beam Profile Challenge



L. Reuen, EUDET Meeting, Paris

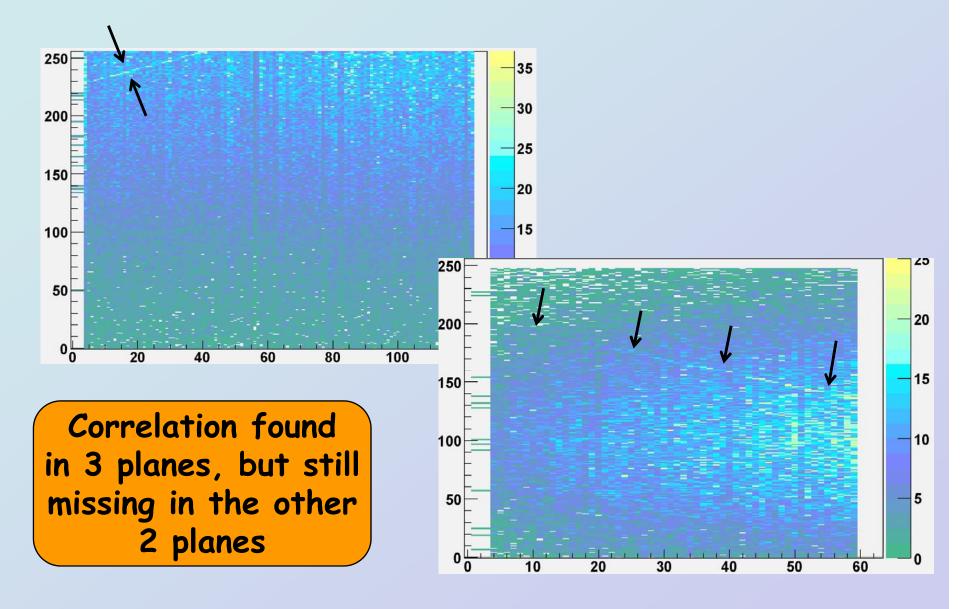
DEPFET to EUTEL Correlation



8.10.2007

L. Reuen, EUDET Meeting, Paris

DEPFET to EUTEL Correlation



L. Reuen, EUDET Meeting, Paris

Summary

- Correlation found for 3 planes
 events synchronized
- High multiplicity will make data analysis a challenge
- Running blind
 - Alignment not good
 - DUT possibly misaligned with
 2 planes

Next steps

- Take a look a low intensity runs
- Convert DEPFET data to LCIO
- Full scale analysis
- TCP/IP data transfer to EUDAQ or
- · Port DEPFET DAQ to Linux
 - → combined data stream
 - → Online Data Monitoring
 - → better alignment